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(54) **SYSTEM AND METHOD FOR A MICROFABRICATED FRACTURE TEST STRUCTURE**

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(58) **Field of Classification Search**

None

See application file for complete search history.

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(57) **ABSTRACT**

According to an embodiment, a micro-fabricated test structure includes a structure mechanically coupled between two rigid anchors and disposed above a substrate. The structure is released from the substrate and includes a test layer mechanically coupled between the two rigid anchors. The test layer includes a first region having a first cross-sectional area and a constricted region having a second cross-sectional area smaller than the first cross-sectional area. The structure also includes a first tensile stressed layer disposed on a surface of the test layer adjacent the first region.

25 Claims, 12 Drawing Sheets